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PATENT  
450100-04444

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: Nobuyuki FUJIWARA et al.  
International Application No.: PCT/JP03/02102  
International Filing Date: February 26, 2003  
For: INFORMATION PROCESSING APPARATUS AND  
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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP03/02102. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

FROMMER LAWRENCE & HAUG LLP  
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By



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Enclosures

Based on Form PTO-1449 (3/90)  LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 450100-04444	SERIAL NO. Filed Concurrently Herewith
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